



General Description

The WSF70P02 is the highest performance trench P-Ch MOSFET with extreme high cell density , which provide excellent RDSON and gate charge for most of the synchronous buck converter applications .

The WSF70P02 meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

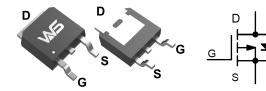
Product Summery

BVDSS	RDSON	N ID	
-20V	6.8mΩ	-70A	

Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

TO-252 Pin Configuration



Absolute Maximum Ratings

		Rating		
Symbol	Parameter	10s	Steady State	Units
V_{DS}	Drain-Source Voltage	-2	20	V
V_{GS}	Gate-Source Voltage	±	12	V
I _D @T _C =25℃	Continuous Drain Current, V _{GS} @ -10V ¹	-7	-70	
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ -10V ¹	-36		Α
I _{DM}	Pulsed Drain Current ²	-200		Α
EAS	Single Pulse Avalanche Energy ³	36	60	mJ
I _{AS}	Avalanche Current -55.4		Α	
P _D @T _C =25℃	Total Power Dissipation ⁴	80		W
T _{STG}	Storage Temperature Range	-55 to	o 150	$^{\circ}$
T_J	Operating Junction Temperature Range	-55 to 150		$^{\circ}$

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction-Ambient ¹		75	°C/W
R _{0JA}	Thermal Resistance Junction-Ambient ¹ (t ≤10s)		40	°C/W
$R_{ heta JC}$	Thermal Resistance Junction-Case ¹		4.2	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =-250uA	-20			V
$\triangle BV_{DSS}/\triangle T_{J}$	BV _{DSS} Temperature Coefficient	Reference to 25℃, I _D =-1mA		-0.018		V/°C
В	Static Drain-Source On-Resistance ²	V _{GS} =-4.5V , I _D =-15A		6.8	9.0	m 0
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =-2.5V , I _D =-10A		8.2	11	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	V _{GS} =V _{DS} . I _D =-250uA	-0.4	-0.6	-1.2	٧
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	V _{GS} -V _{DS} , I _D 250uA		2.94		mV/℃
	Drain Source Loakage Current	V _{DS} =-20V , V _{GS} =0V , T _J =25℃			1	
I _{DSS}	Drain-Source Leakage Current	V_{DS} =-20V , V_{GS} =0V , T_J =55 $^{\circ}$ C			5	uA
I _{GSS}	Gate-Source Leakage Current	V_{GS} = $\pm12V$, V_{DS} = $0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =-5V , I _D =-10A		45		8
Qg	Total Gate Charge (-4.5V)			63		
Q_gs	Gate-Source Charge	V _{DS} =-15V , V _{GS} =-4.5V , I _D =-10A		9.1		nC
Q_gd	Gate-Drain Charge			13		
T _{d(on)}	Turn-On Delay Time			16		
T _r	Rise Time	V _{DD} =-10V , V _{GS} =-4.5V ,		77		no
$T_{d(off)}$	Turn-Off Delay Time	$R_G=3.3\Omega$, $I_D=-10A$		195		ns
T _f	Fall Time			186		
C _{iss}	Input Capacitance			5783		
Coss	Output Capacitance	V _{DS} =-10V , V _{GS} =0V , f=1MHz		520		pF
C _{rss}	Reverse Transfer Capacitance			445		

Guaranteed Avalanche Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
EAS	Single Pulse Avalanche Energy ⁵	V _{DD} =-10V , L=0.5mH , I _{AS} =-50A	120			mJ

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,6}	V _G =V _D =0V , Force Current			-70	Α
I _{SM}	Pulsed Source Current ^{2,6}				-200	Α
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =-1A , T _J =25℃			-1.2	V
t _{rr}	Reverse Recovery Time	IF=-10A , dI/dt=100A/µs ,		31		nS
Q _{rr}	Reverse Recovery Charge	T _J =25℃		22		nC

Note:

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper ,t<10sec.
- 2.The data tested by pulsed , pulse width $\,\leq\,300\text{us}$, duty cycle $\,\leq\,2\%$
- 3. The EAS data shows Max. rating . The test condition is V_{DD} =-10V, V_{GS} =-4.5V, L=0.5mH, I_{AS} =-50A
- 4. The power dissipation is limited by 150 ℃ junction temperature
- 5. The Min. value is 100% EAS tested guarantee.
- 6. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



Typical Characteristics

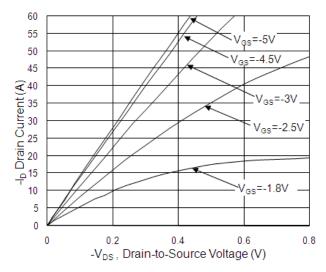


Fig.1 Typical Output Characteristics

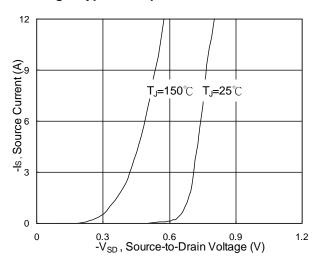


Fig.3 Forward Characteristics of Reverse

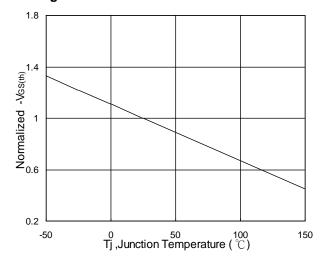


Fig.5 Normalized $V_{\text{GS(th)}}$ vs. T_{J}

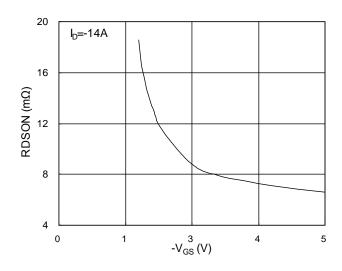


Fig.2 On-Resistance vs. G-S Voltage

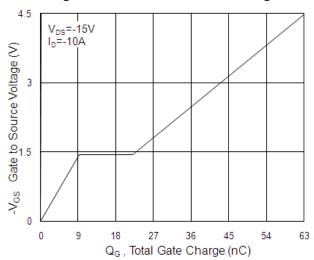


Fig.4 Gate-charge Characteristics

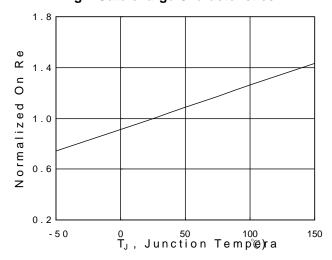
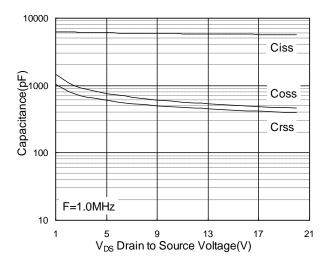


Fig.6 Normalized R_{DSON} vs. T_J





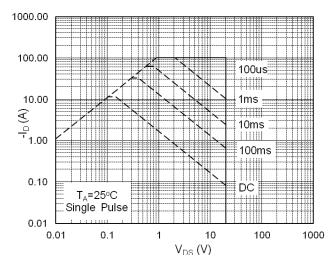


Fig.7 Capacitance

Fig.8 Safe Operating Area

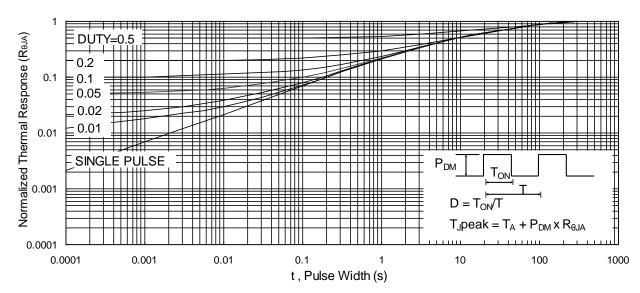
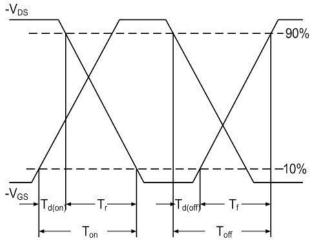


Fig.9 Normalized Maximum Transient Thermal Impedance





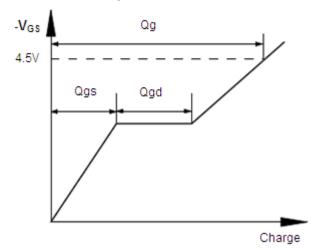


Fig.11 Gate Charge Waveform



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